

Notice of References Cited	Application/Control No. 10/559,830		Applicant(s)/Patent Under Reexamination MINAKATA ET AL.	
	Examiner Michael A. Strieb		Art Unit 4177	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,671,062	09-1997	Nakamura, Akira	359/687
*	B	US-2,908,209	10-1959	MARVIN EDGAR S; et. al.	359/826
*	C	US-5,812,317	09-1998	Billingsley et al.	359/536
*	D	US-6,107,396	08-2000	Kweon et al.	524/779
*	E	US-5,541,656	07-1996	Kare et al.	348/333.02
*	F	US-6,353,504	03-2002	Yamamoto, Chikara	359/686
*	G	US-6,635,352	10-2003	Shirakawa, Hiroshi	428/447
*	H	US-3,118,198	01-1964	PRUNIER LOUIS J	164/98
*	I	US-2,250,597	07-1941	MOULTON HAROLD R	351/168
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2003-248106	05-2003	Japan	Nakano et al	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

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